

<b>Notice of References Cited</b>	Application/Control No. 09/873,312		Applicant(s)/Patent Under Reexamination OSHIMA ET AL.	
	Examiner Vadim Dudnikov		Art Unit 3663	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,378,895	01-1995	Cole et al.	250/390.04
*	B	US-5,999,588	12-1999	Shao et al.	378/4
*	C	US-6,159,413 B1	12-2000	Katoh et al.	264/447
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Press Releases (1999/12/16 "High-Sensitivity/High-Precision Quantification Method of Trace Elements Developed by JAERI". 1999)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.